

Notice of References Cited	Application/Control No. 10/026,836	Applicant(s)/Patent Under Reexamination BEDINGFIELD, JAMES C.	
	Examiner Jonathan Ouellette	Art Unit 3629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,944,769	08-1999	Musk et al.	701/201
*	B	US-2002/0013815	01-2002	Obradovich et al.	709/204
*	C	US-6,587,835	07-2003	Treyz et al.	705/14
*	D	US-6,240,425	05-2001	Naughton, John	707/104.1
*	E	US-2002/0029226	03-2002	Li et al.	707/104.1
*	F	US-6,523,021	02-2003	Monberg et al.	707/2
*	G	US-2002/0035609	03-2002	Lessard et al.	709/217
*	H	US-2002/0116121	08-2002	Ruiz et al.	701/208
*	I	US-2002/0116287	08-2002	Schubert et al.	705/26
*	J	US-2003/0158655	08-2003	Obradovich et al.	701/207
*	K	US-6,148,090	11-2000	Narioka, Hiroto	382/113
*	L	US-6,947,976	09-2005	Devitt et al.	709/219
*	M	US-6,317,686	11-2001	Ran, Bin	701/210

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.